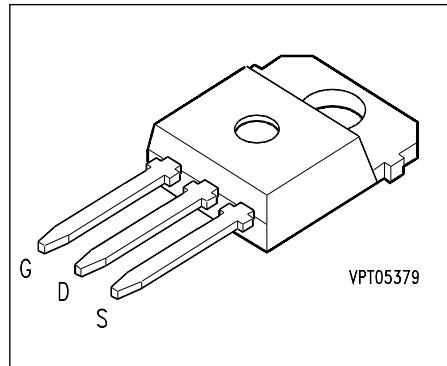


## SIPMOS® Power Transistors

**BUZ 355  
BUZ 356**

- N channel
- Enhancement mode



Type	$V_{DS}$	$I_D$	$T_c$	$R_{DS\ (on)}$	Package <sup>1)</sup>	Ordering Code
<b>BUZ 355</b>	800 V	6.0 A	29 °C	1.5 Ω	TO-218 AA	C67078-A3107-A2
<b>BUZ 356</b>	800 V	5.3 A	25 °C	2.0 Ω	TO-218 AA	C67078-A3108-A2

### Maximum Ratings

Parameter	Symbol	BUZ		Unit
		355	356	
Continuous drain current	$I_D$	<b>6.0</b>	<b>5.3</b>	A
Pulsed drain current, $T_c = 25$ °C	$I_{D\ puls}$	<b>21</b>		
Drain source voltage	$V_{DS}$	<b>800</b>		V
Drain-gate voltage, $R_{GS} = 20$ kΩ	$V_{DGR}$	<b>800</b>		
Gate-source voltage	$V_{GS}$	<b>± 20</b>		
Power dissipation, $T_c = 25$ °C	$P_{tot}$	<b>125</b>		W
Operating and storage temperature range	$T_j, T_{stg}$	<b>– 55 ... + 150</b>		°C

Thermal resistance, chip-case	$R_{th\ JC}$	<b>≤ 1.0</b>	K/W
DIN humidity category, DIN 40 040		<b>C</b>	–
IEC climatic category, DIN IEC 68-1		<b>55/150/56</b>	

1) See chapter Package Outlines.

**Electrical Characteristics**at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Static characteristics**

Drain-source breakdown voltage $V_{GS} = 0 \text{ V}, I_D = 0.25 \text{ mA}$	$V_{(BR) DSS}$	800	–	–	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	$V_{GS (\text{th})}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	$I_{DSS}$	–	20	250	$\mu\text{A}$
–	–	100	1000		
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	$I_{GSS}$	–	10	100	nA
Drain-source on-resistance $V_{GS} = 10 \text{ V}, I_D = 3.0 \text{ A}$ BUZ 355 BUZ 356	$R_{DS (\text{on})}$	–	1.3	1.5	$\Omega$
	–	1.6	2.0		

**Dynamic characteristics**

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}, I_D = 3.0 \text{ A}$	$g_{fs}$	1.8	3.0	–	S
Input capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{iss}$	–	3.9	5.0	pF
Output capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{oss}$	–	200	350	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{rss}$	–	80	140	
Turn-on time $t_{on}$ , ( $t_{on} = t_{d(on)} + t_r$ ) $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}, R_{GS} = 50 \Omega$	$t_{d(on)}$	–	60	90	ns
	$t_r$	–	90	140	
Turn-off time $t_{off}$ , ( $t_{off} = t_{d(off)} + t_f$ ) $V_{DD} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}, R_{GS} = 50 \Omega$	$t_{d(off)}$	–	330	430	
	$t_f$	–	110	140	

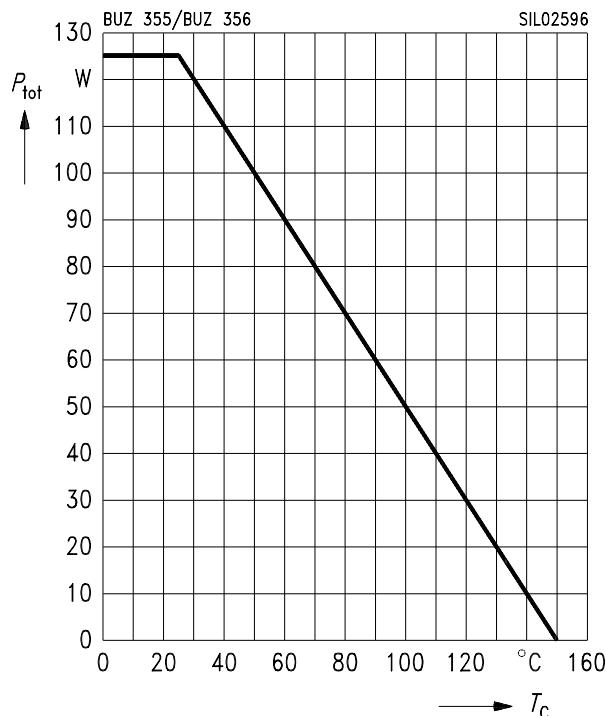
**Electrical Characteristics** (cont'd)  
at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

<b>Parameter</b>	<b>Symbol</b>	<b>Values</b>			<b>Unit</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>	
<b>Reverse diode</b>					
Continuous reverse drain current $T_C = 25^\circ\text{C}$	$I_S$	—	—	6.0	A
BUZ 355		—	—	5.3	
BUZ 356					
Pulsed reverse drain current $T_C = 25^\circ\text{C}$	$I_{SM}$	—	—	24	
BUZ 355		—	—	21	
BUZ 356					
Diode forward on-voltage $I_S = 12 \text{ A}, V_{GS} = 0 \text{ V}$	$V_{SD}$	—	1.1	1.5	V
Reverse recovery time $V_R = 100 \text{ V}, I_F = I_S, di_F / dt = 100 \text{ A}/\mu\text{s}$	$t_{rr}$	—	1.8	—	$\mu\text{s}$
Reverse recovery charge $V_R = 100 \text{ V}, I_F = I_S, di_F / dt = 100 \text{ A}/\mu\text{s}$	$Q_{rr}$	—	25	—	$\mu\text{C}$

**Characteristics** at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

### Total power dissipation

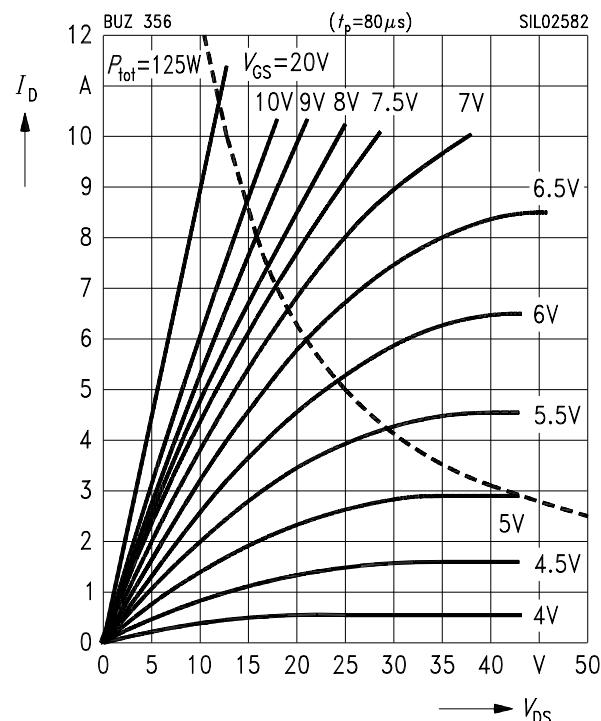
$$P_{\text{tot}} = f(T_C)$$



### Typ. output characteristics

$$I_D = f(V_{DS})$$

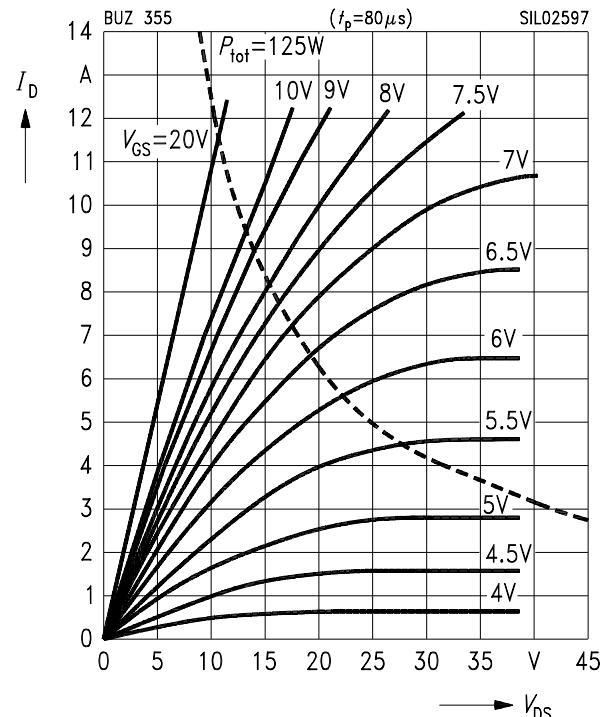
parameter:  $t_p = 80 \mu\text{s}$



### Typ. output characteristics

$$I_D = f(V_{DS})$$

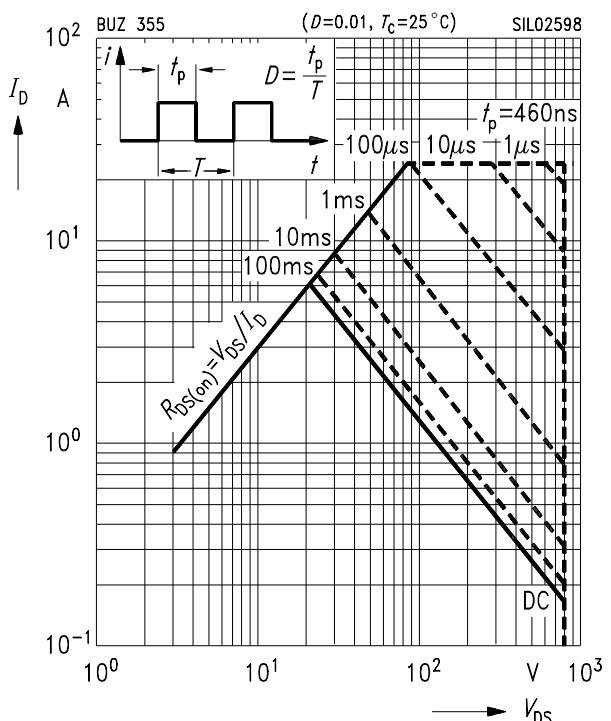
parameter:  $t_p = 80 \mu\text{s}$



### Safe operating area

$$I_D = f(V_{DS})$$

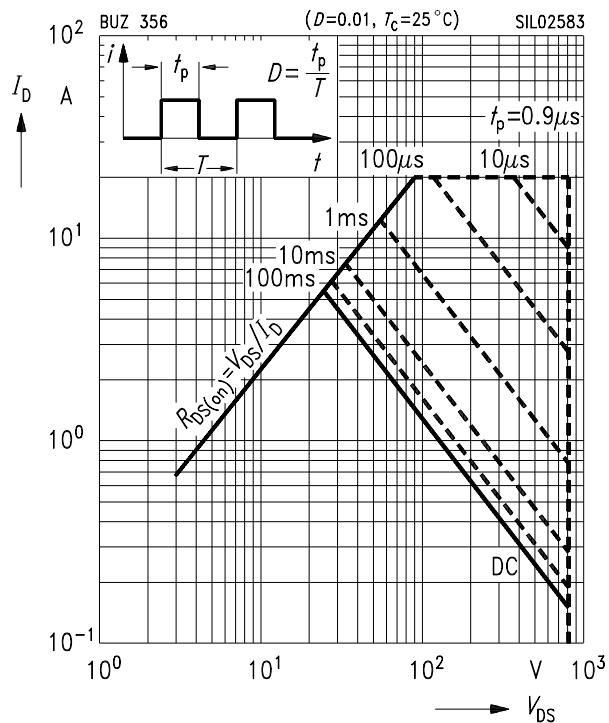
parameter:  $D = 0.01, T_C = 25^\circ\text{C}$



### Safe operating area

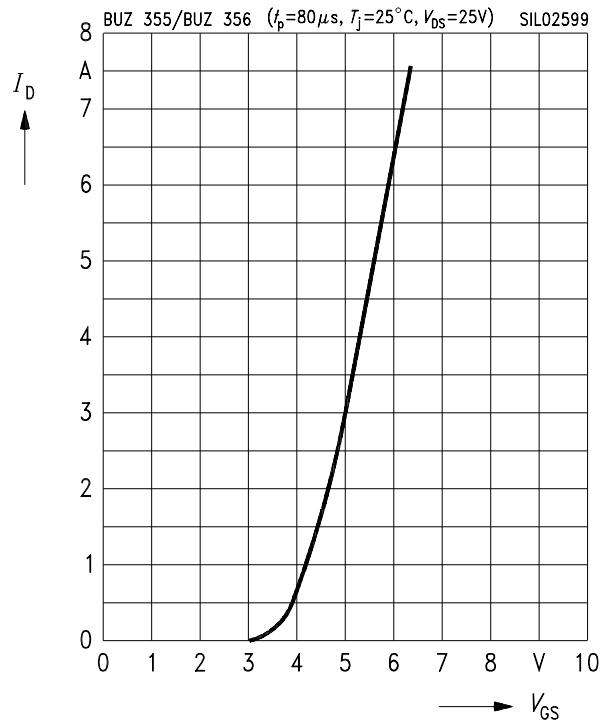
$I_D = f(V_{DS})$   
parameter:  $D = 0.01, T_C = 25^\circ C$

**BUZ 356**



### Typ. transfer characteristics

$I_D = f(V_{GS})$   
parameter:  $t_p = 80 \mu s, V_{DS} = 25 V$



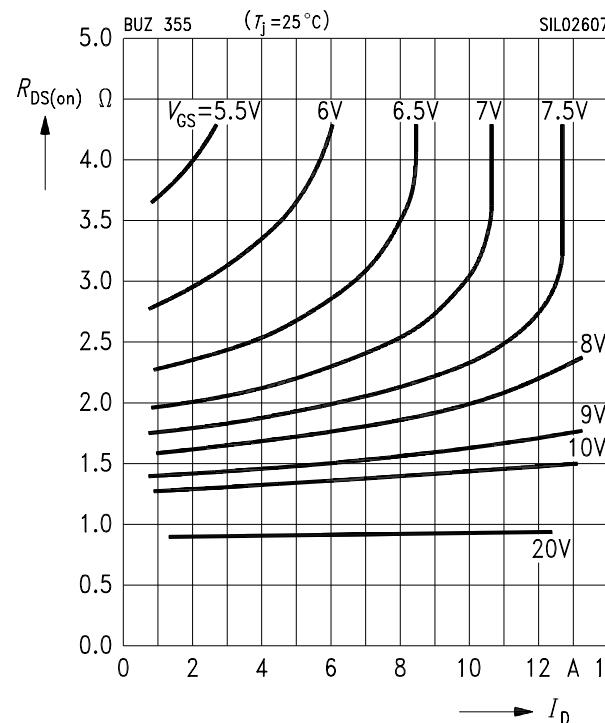
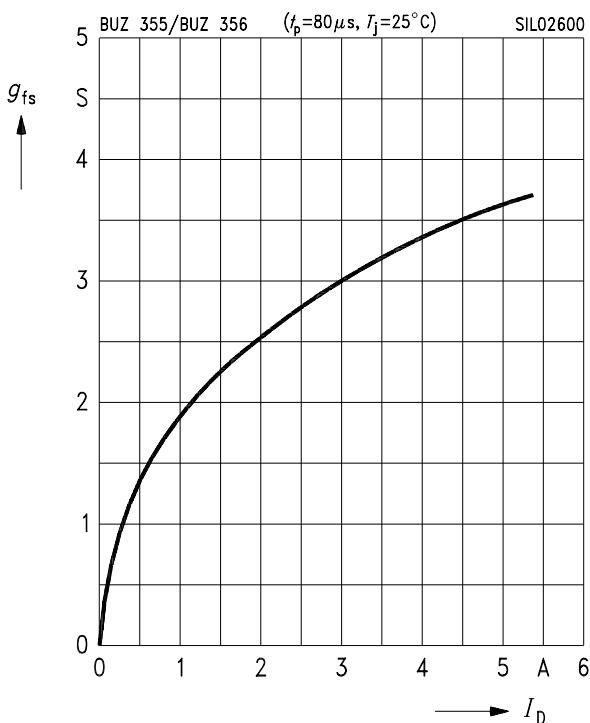
### Typ. forward transconductance

$g_{fs} = f(I_D)$   
parameter:  $t_p = 80 \mu s$

### Typ. drain-source on-resistance

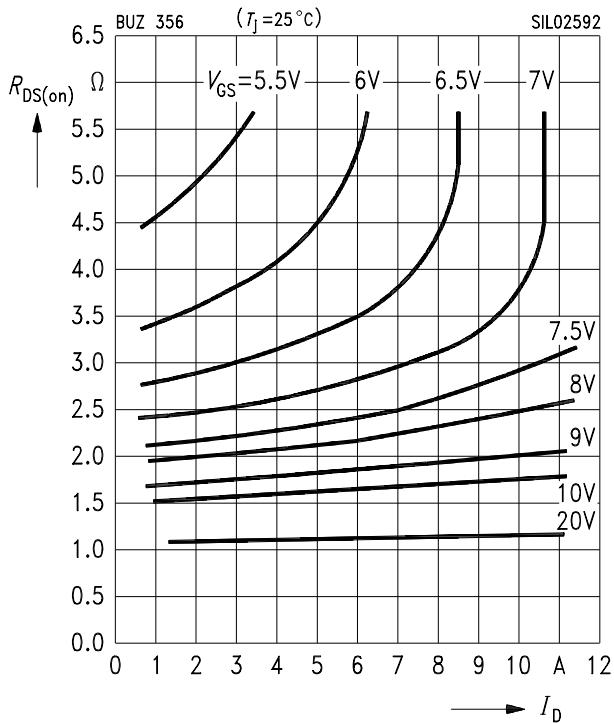
$R_{DS(on)} = f(I_D)$   
parameter:  $V_{GS}$

**BUZ 355**



### Typ. drain-source on-resistance

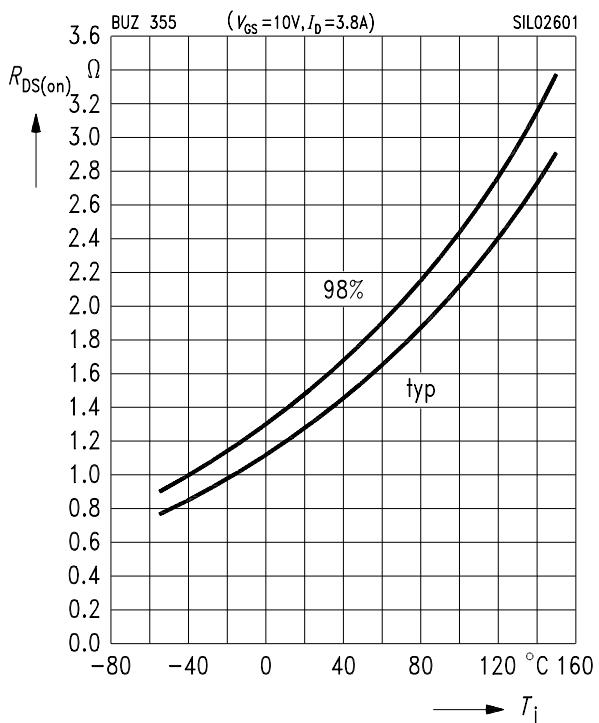
$R_{DS(on)} = f(I_D)$   
parameter:  $V_{GS}$



**BUZ 356**

### Drain-source on-resistance

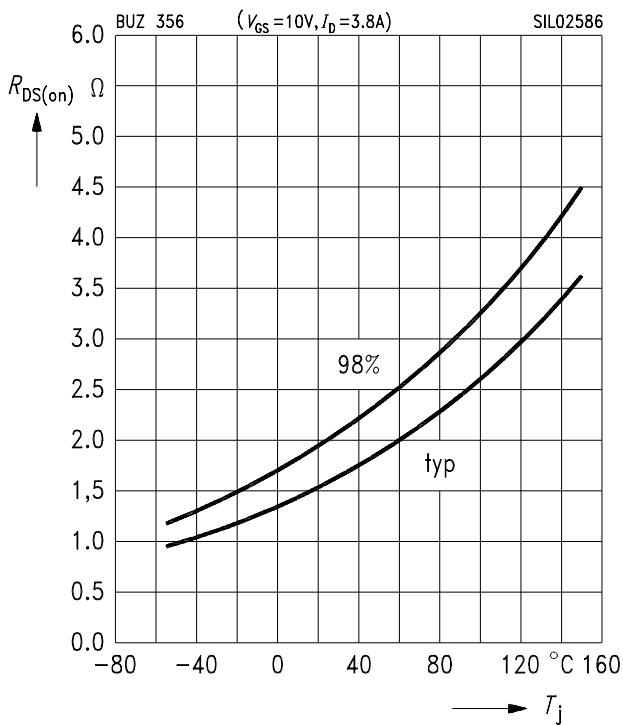
$R_{DS(on)} = f(T_j)$   
parameter:  $I_D = 3.8 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$ , (spread)



**BUZ 355**

### Drain-source on-resistance

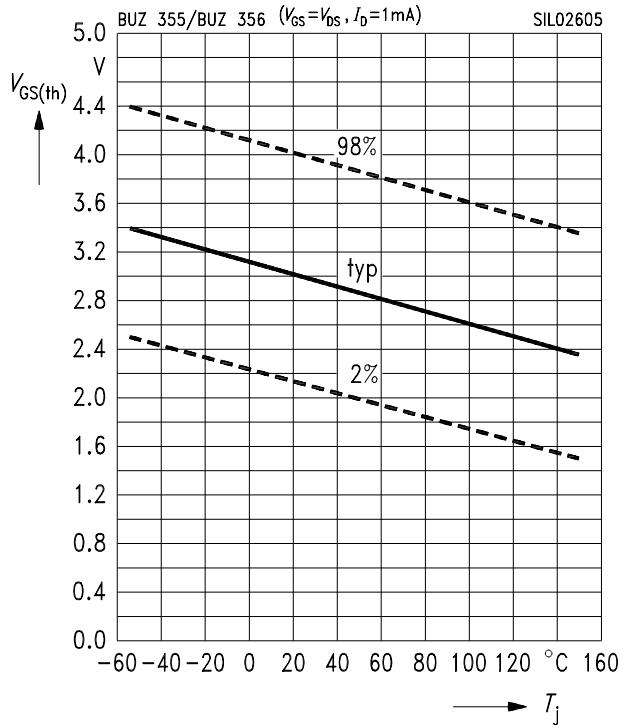
$R_{DS(on)} = f(T_j)$   
parameter:  $I_D = 3.8 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$ , (spread)



**BUZ 356**

### Gate threshold voltage

$V_{GS(th)} = f(T_j)$   
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1 \text{ mA}$ , (spread)

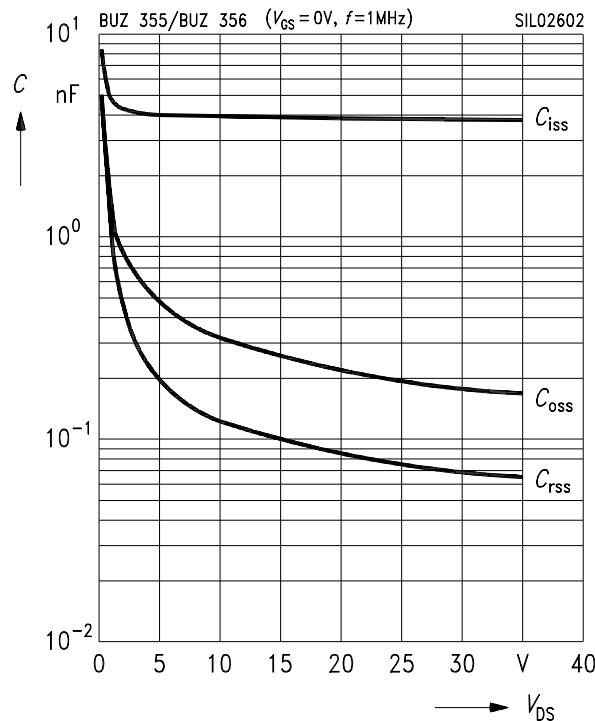


**SIL02605**

### Typ. capacitances

$$C = f(V_{DS})$$

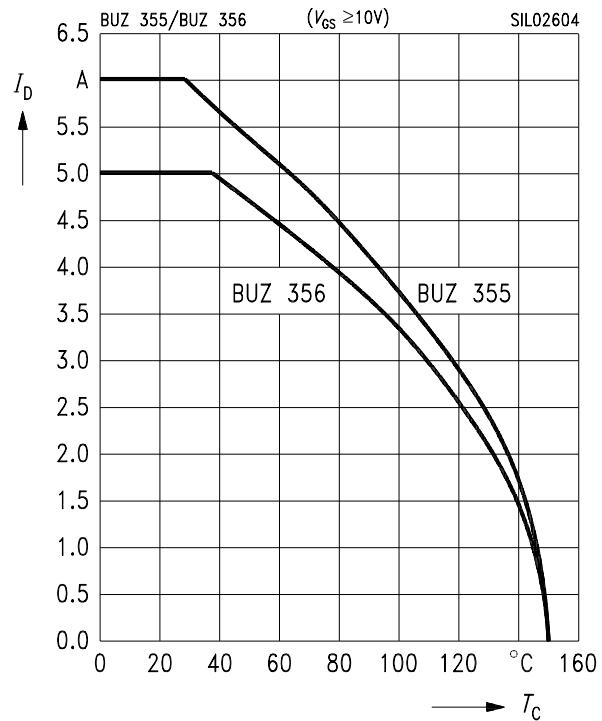
parameter:  $V_{GS} = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$



### Drain current

$$I_D = f(T_C)$$

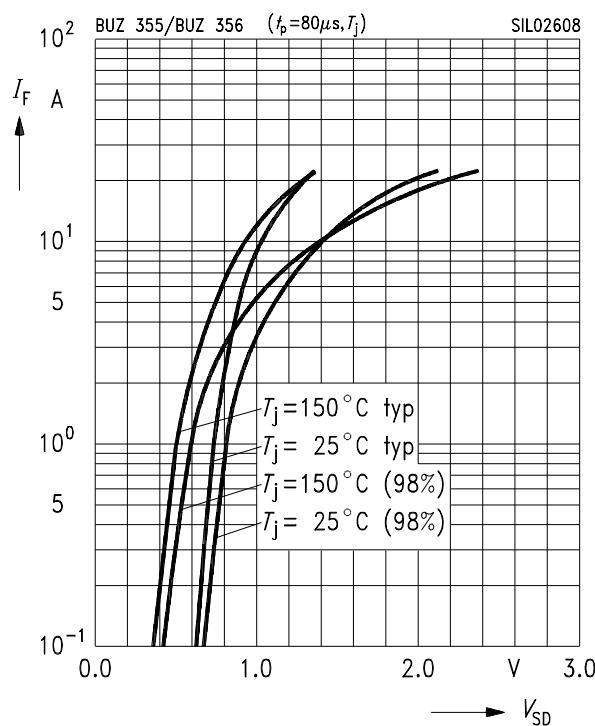
parameter:  $V_{GS} \geq 10 \text{ V}$



### Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

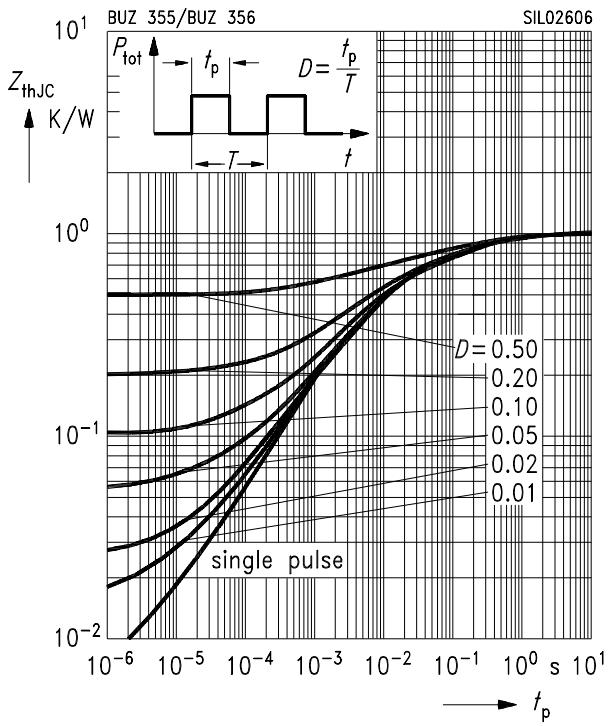
parameter:  $T_j, t_p = 80 \mu\text{s}$ , (spread)



### Transient thermal impedance

$$Z_{thJC} = f(t_p)$$

parameter:  $D = t_p / T$



**Typ. gate charge**

$$V_{GS} = f(Q_{Gate})$$

parameter:  $I_D$  puls = 9 A

